

**Notice of References Cited**

Application/Control No.

10/645,807

Applicant(s)/Patent Under

Reexamination

LIN ET AL.

Examiner

TUAN H. NGUYEN

Art Unit

2618

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**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-7,158,812	01-2007	Lee et al.	455/561
	B	US-			
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
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	K	US-			
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	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
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**NON-PATENT DOCUMENTS**

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